

<b>Notice of References Cited</b>	Application/Control No. 10/549,585		Applicant(s)/Patent Under Reexamination HIRAYAMA ET AL.	
	Examiner KEVIN M. JOHNSON		Art Unit 1793	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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#### FOREIGN PATENT DOCUMENTS

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	N	JP 2003336055 A	11-2003	Japan	SETOGUCHI et al.	C09K 11/64
	O					
	P					
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#### NON-PATENT DOCUMENTS

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